



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Christian Wagner et al. Art Unit : 2161
Serial No. : 09/934,817 Examiner : Etienne Pierre Leroux
Filed : August 21, 2001 Conf. No. : 9363
Title : OPTICAL ARRANGEMENT AND PROJECTION EXPOSURE SYSTEM FOR
MICROLITHOGRAPHY WITH PASSIVE THERMAL COMPENSATION

MAIL STOP RCE

Commissioner for Patents
P.O. Box 1450
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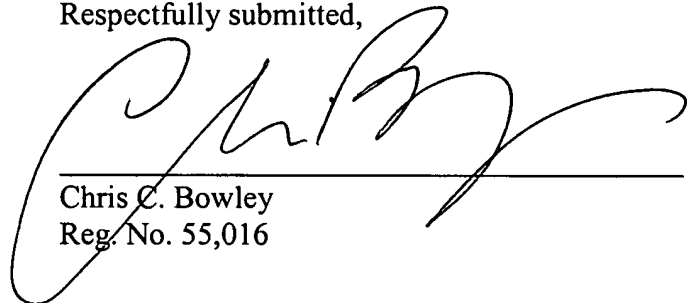
INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: 1/12/2007

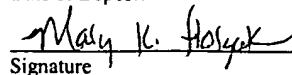

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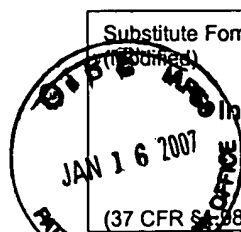
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CERTIFICATE OF MAILING BY FIRST CLASS MAIL

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January 12, 2007
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Signature

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Typed or Printed Name of Person Signing Certificate

	Substitute Form PTO-1449 (37 CFR § 1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 17979-050001	Application No. 09/934,817
	Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Christian Wagner et al.	
			Filing Date August 21, 2001	Group Art Unit 2161

U.S. Patent Documents

Examiner Initial		Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	AB	3,587,063	June 22, 1971	Lamberts et al.			
	AC	AD	3,626,176	Dec. 7, 1971	Taisuke Tsugami			
	AE	AF	4,155,631	May 22, 1979	Borsare et al.			
	AG	AH	4,459,016	July 10, 1984	Tokuhara et al.			
	AI	AJ	4,577,305	Mar. 18, 1986	Allen et al.			
	AK	AL	4,595,273	June 17, 1986	Watanabe et al.			
	AM	AN	4,668,077	May 26, 1987	Tanaka			
	AO	AP	4,739,396	April 19, 1988	Hyatt			
	AQ	AR	4,846,578	July 11, 1989	Morita et al.			
	AS	AT	4,855,792	Aug. 8, 1989	Holbrook et al.			
	AU	AV	5,313,333	May 17, 1994	O'Brien et al.			
	AW	AX	5,557,413	Sept. 17, 1996	Ebihara et al.			
	AY	AZ	5,557,474	Sept. 17, 1996	McCrary			
	AAA	ABB	5,738,165	April 14, 1998	Imai			
	ACC	ADD	5,741,056	April 21, 1998	Liu			
	AEE	AFF	5,764,312	June 9, 1998	Okumura			
	AGG	AHH	5,805,273	Sept. 8, 1998	Unno			
	AII	AJJ	5,883,704	Mar. 16, 1999	Nishi et al.			
	AKK	ALL	5,953,106	Sept. 14, 1999	Unno et al.			
	AMM	ANN	6,038,013	Mar. 14, 2000	Ohsaki			
	AOO	APP	6,211,896	April 3, 2001	Morton			
	AQQ	ARR	2003/0142785	July 31, 2003	Kageyama			
	ASS	ATT						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AUU	EP 0678768	Oct. 25, 1995	Europe				

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 17979-050001	Application No. 09/934,817
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Christian Wagner et al.	
		Filing Date August 21, 2001	Group Art Unit 2161

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AVV	EP 0853357	July 15, 1998	Europe				
	AWW	EP 0938009	Aug. 25, 1999	Europe				no
	AXX	EP 0938009	Aug. 25, 1999	Europe (abstract)			yes	
	AYY	EP 1596235	Nov. 16, 2005	Europe				no
	AZZ	EP 1596235	Nov. 16, 2005	Europe (abstract)			yes	
	AAAA	JP 59150488	Aug. 28, 1984	Japan				no
	ABBB	JP 59150488	Aug. 28, 1984	Japan (abstract)			yes	
	ACCC	JP 59175178	Oct. 3, 1984	Japan				no
	ADDD	JP 59175178	Oct. 3, 1984	Japan (abstract)			yes	
	AEEE	JP 61208002	Sept. 16, 1986	Japan				no
	AFFF	JP 61208002	Sept. 16, 1986	Japan (abstract)			yes	
	AGGG	JP 06003510	Jan. 14, 1994	Japan				no
	AHHH	JP 06003510	Jan. 14, 1994	Japan (abstract)			yes	
	AIII							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AJJJ	
	AKKK	

Examiner Signature	Date Considered
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